

Notice of References Cited	Application/Control No. 10/044,541		Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
	Examiner Lana N. Le		Art Unit 2685	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0039059	04-2002	Kanba et al.	333/204
*	B	US-2005/0184832	08-2005	Ono et al.	333/204
*	C	US-6,633,207	10-2003	Hidaka et al.	333/134
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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